Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,612	CHIEN, HIGHLY	
Examiner	Art Unit	
CongVan Tran	2688	

SEARCHED				
	JEAR			
Class	Subclass	Date	Examiner	
455	553.1 401 403 343.3 344 348	2/15/2006	СТ	
379	207.1-10	2/15/2006	ст	
-				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
455	403		

(INCLUDING SE	CH NOTES ARCH STRATEGY	)
	DATE	EXMR
Updated serach	2/16/2006	ст
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